

Introduction

The PE44951 includes highly integrated phase shifters with digitally controlled step attenuators for use across the 6.025 to 7.525 GHz frequency range. Due to the high resolution of the digital phase shifters and digital step attenuators, the loss and phase shift associated with the PCB traces of the evaluation board must be accounted for to ensure that only the associated phase and insertion of the PE44951 is evaluated. This application note demonstrates the method of bifurcation of the thru trace to accurately remove the phase and associated insertion loss of the PCB traces on the PE44951 evaluation kit (EVK).

Bifurcation method

pSemi designed this application note using the Keysight PNA-X N5245B, License S93007B — Automatic Fixture Removal (AFR) for the bifurcation of the thru trace into two separate traces where each trace has its own phase and associated trace loss. Although this application note is based on the Keysight PNA-X, other vector network analyzers (VNAs) offer similar features.

VNA E-calibration

The first step is to run ECAL on the VNA to remove the associated phase and insertion loss of the port extensions for Port 1, Port 2, and Port 3. The AFR requires the start and step of the E-calibration to be equivalent, so configure your E-calibration sweep for 10 MHz to 10 GHz and 1000 points.

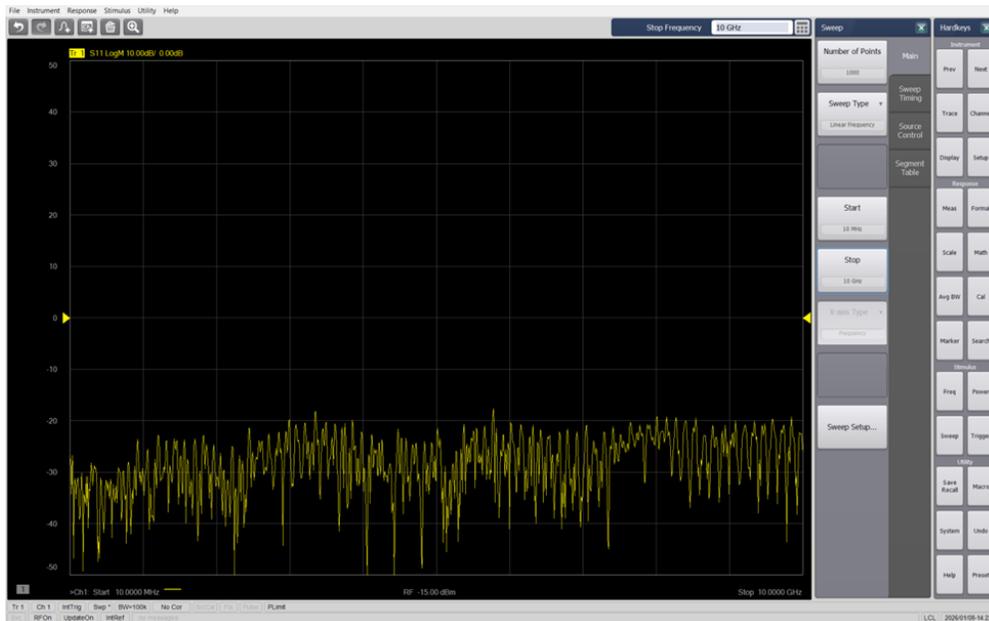


Figure 1: E-calibration sweep

Auto fixture removal tool setup

To ensure that the phase and associated loss of the thru trace is removed, change the measurement on the VNA to S21 and update the marker to reflect measuring the associated phase and loss of the trace using the following VNA settings:

Marker → Marker Setup → Format Log/Phase

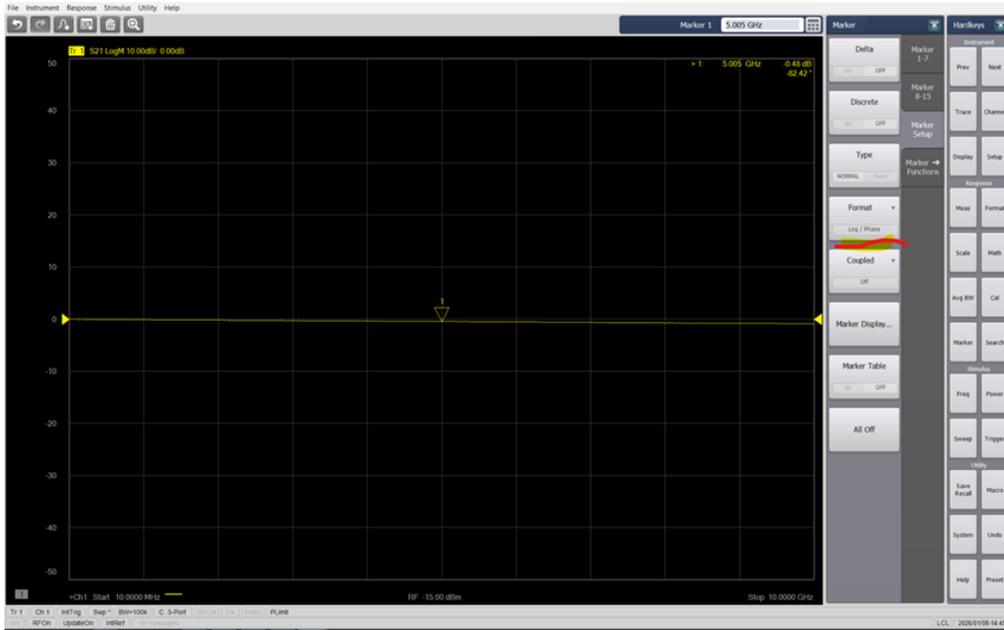


Figure 3: Update the VNA marker for AFR

To compensate for the THRU trace, go to the AFR tool location:

CAL → Fixtures → Auto Fixture Removal

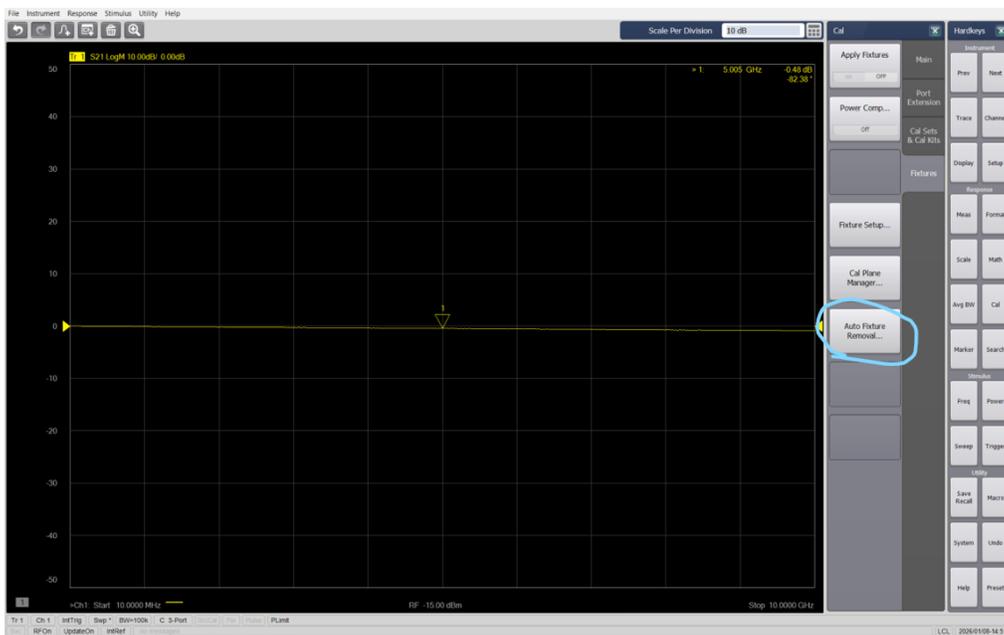


Figure 4: Automatic fixture removal location

Auto fixture removal tool application

In the Auto Fixture Removal application, configure tabs 1–5 as shown in Figure 5–Figure 9.

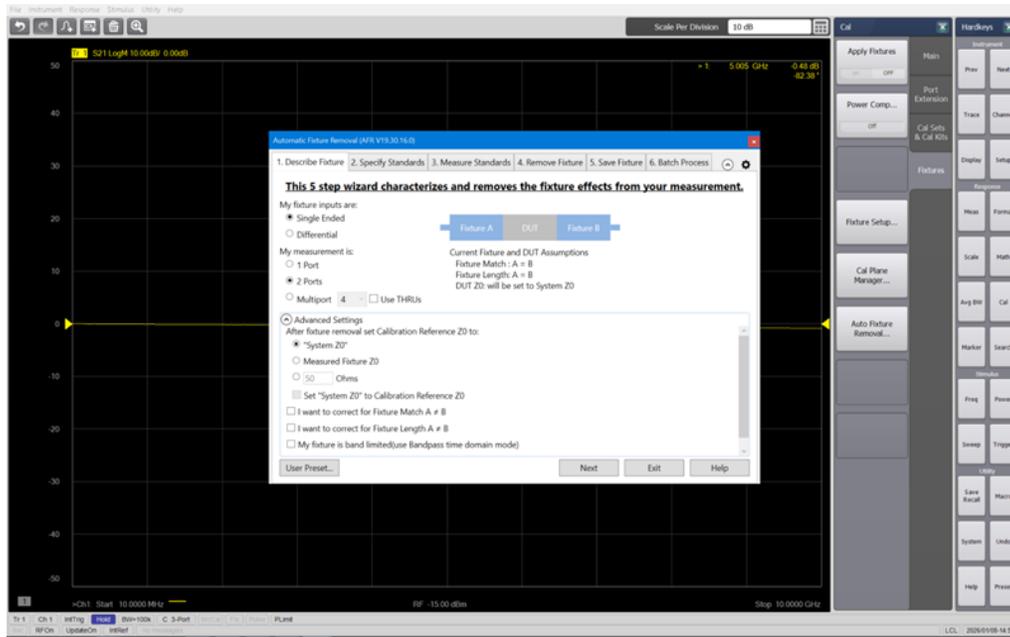


Figure 5: AFR tool tab 1

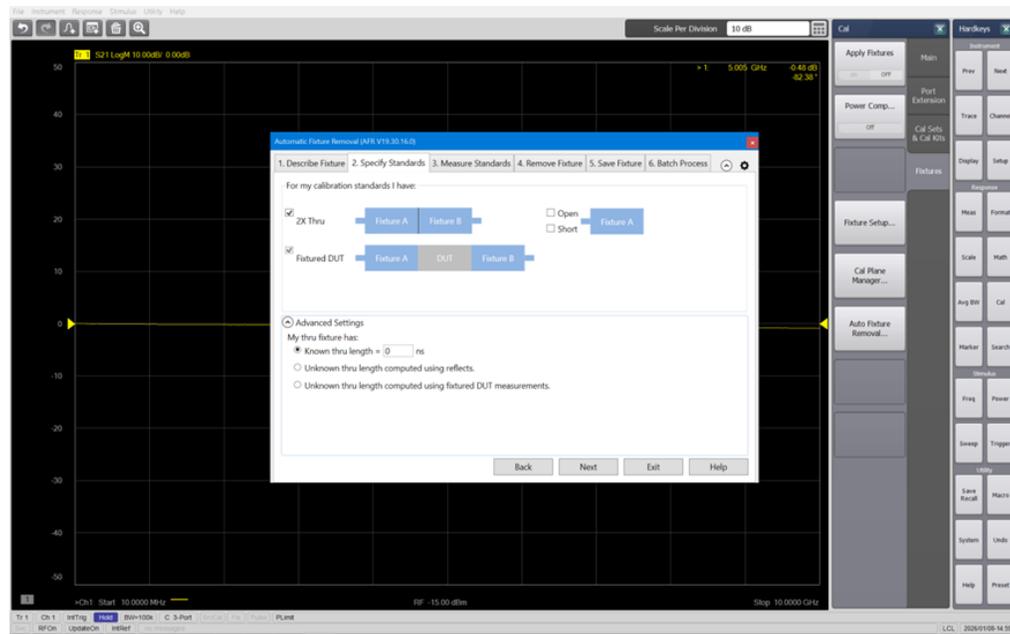


Figure 6: AFR tool tab 2

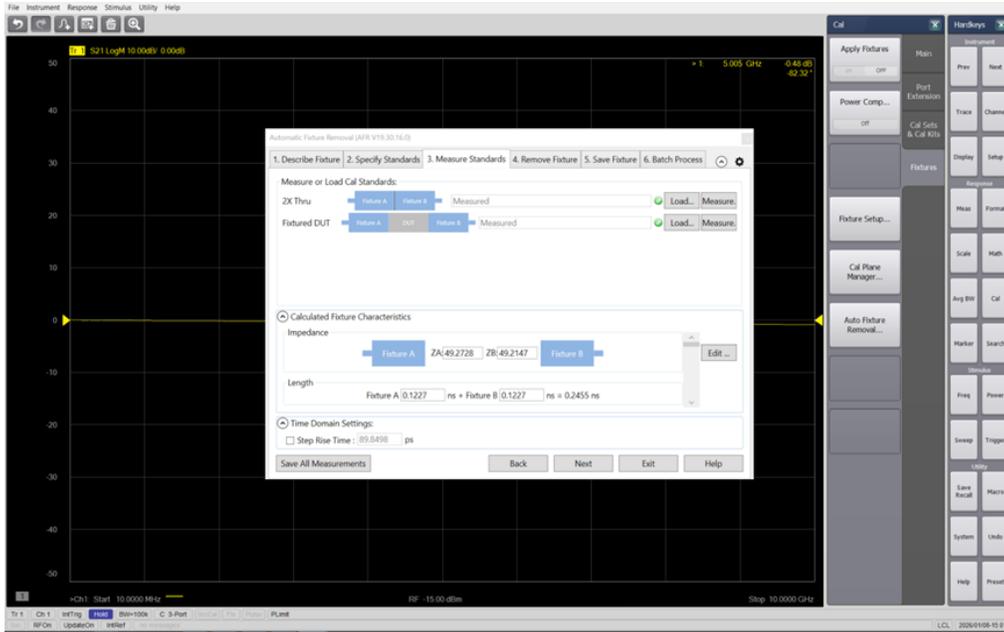


Figure 7: AFR tool tab 3

On tab 3, run **2X Thru** and **Fixed DUT**. After the measurements complete, the characteristics of the bifurcated trace display. For example, section A displays the following:

- Impedance: 49.27Ω
- Delay: 0.12 ns

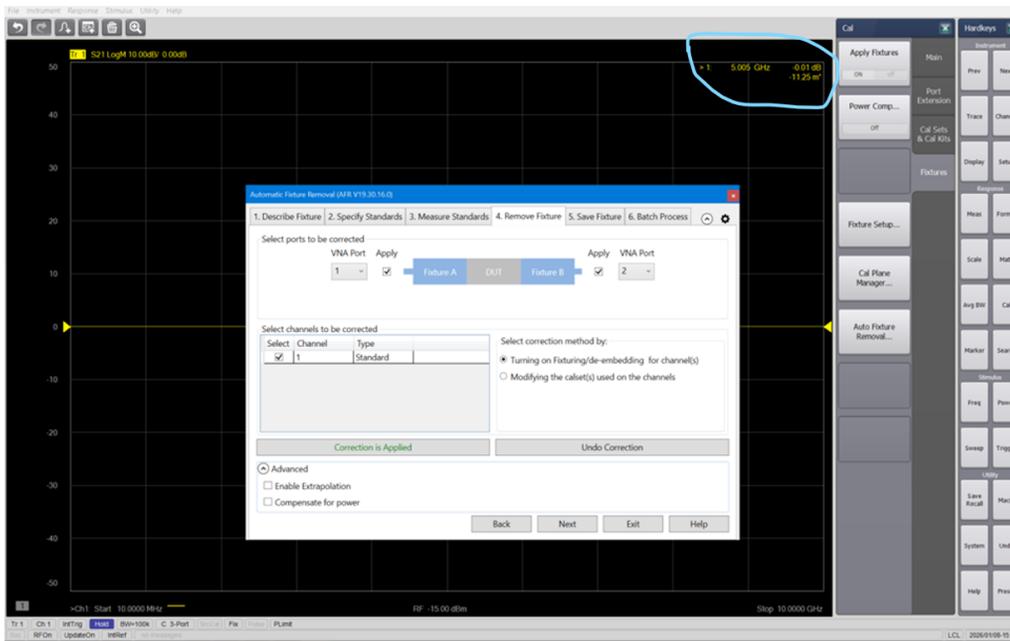


Figure 8: AFR tool tab 4

On tab 4, select **Apply Correction** and verify that the magnitude and the phase of the trace are removed from the S21 measurement with a loss of 0.01 dB and a phase of 11.22 m degrees.

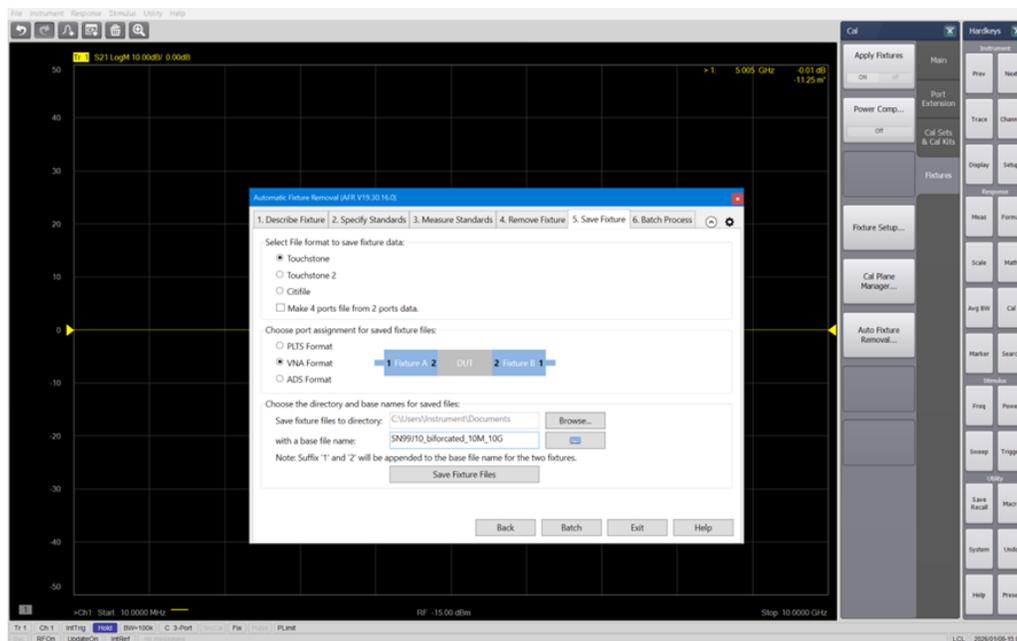


Figure 9: AFR tool tab 5

In tab 5, save the files by following this procedure:

1. In the *Save future files to this directory* field, enter or browse to the folder.
2. In the *with a base file name* field, enter the file name. In the Figure 9 example, the specified file name is SN99J10_biforcated_10M_10G.
3. To save the files, select **Save Fixture Files**.
4. After the files are saved, select **Exit**.

Auto fixture removal tool fixture setup

Now that the bifurcation of the Thru trace and its associated SNP files have been calculated and saved, configure the fixture setup as shown below to implement the locations of the traces according to the PE44951 EVK.

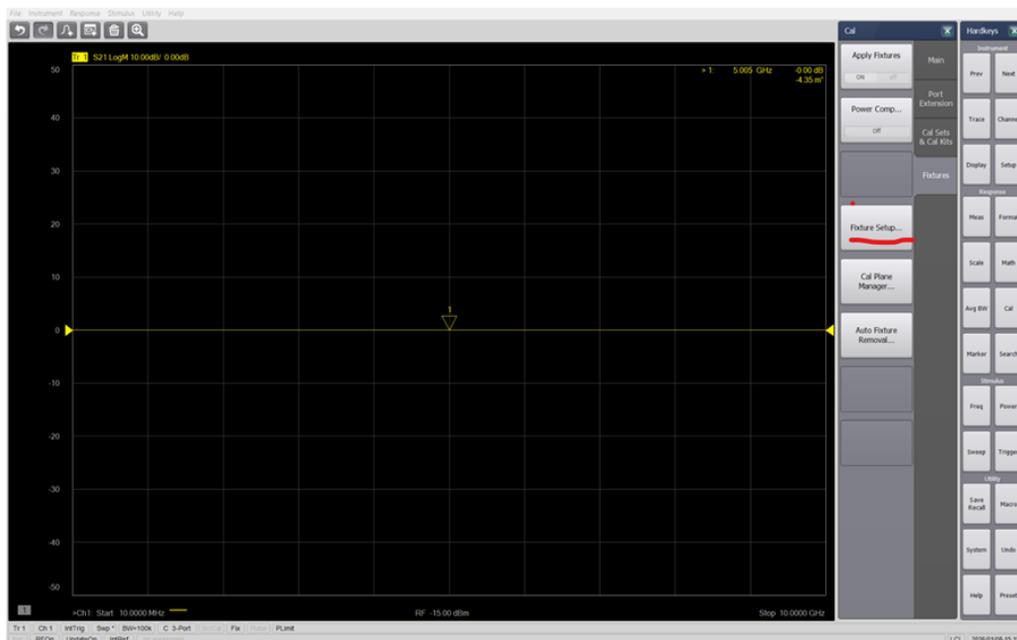


Figure 10: Fixture setup to match the EVK trace location

As shown in Figure 11, the PE44951 EVK has three ports, so the bifurcation must be added as follows:

- Port A gets the first part of the bifurcation.
- Ports B and C get the second part of the bifurcation because they are after the chipset.



Figure 11: PE44951 EVK trace location

To verify that the Fixture Setup was correctly applied, follow this procedure:

1. Set the VNA to measure the S31 S-parameter.
2. Connect VNA port 1 to the EVK J5 thru port connector.
3. Connect VNA port 3 to the EVK J4 thru port connector.
4. Verify that you can measure S31 through the thru trace as shown in Figure 14.

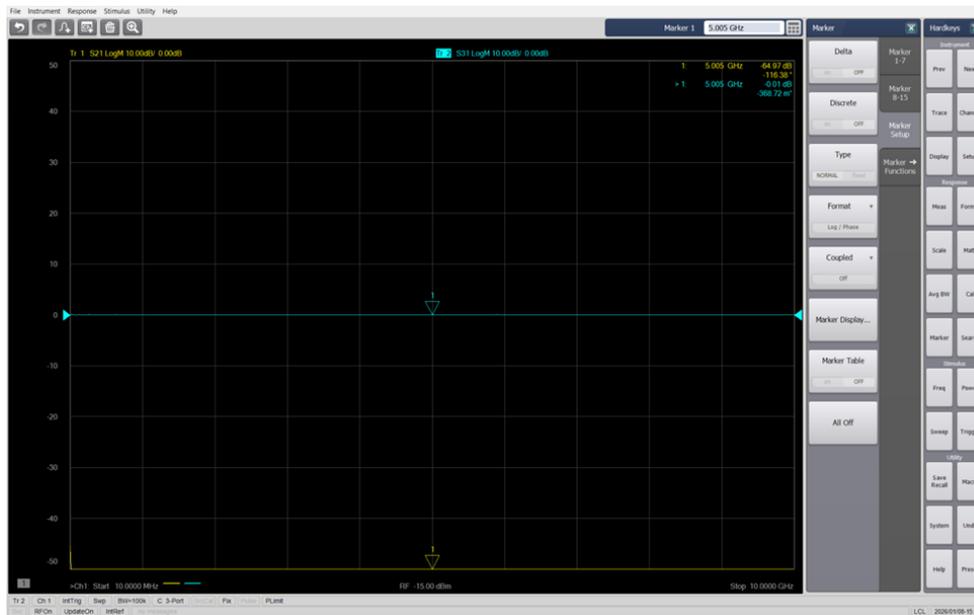


Figure 14: S31 measurement to verify the AFR fixture setup

Conclusion

This application note described how to use bifurcation to take the loss and phase shift associated with the PCB traces of the PE44951 EVK board into account.

Sales contact

For additional information, contact Sales at sales@psemi.com.

Disclaimers

The information in this document is believed to be reliable. However, pSemi assumes no liability for the use of this information. Use shall be entirely at the user's own risk. No patent rights or licenses to any circuits described in this document are implied or granted to any third party. pSemi's products are not designed or intended for use in devices or systems intended for surgical implant, or in other applications intended to support or sustain life, or in any application in which the failure of the pSemi product could create a situation in which personal injury or death might occur. pSemi assumes no liability for damages, including consequential or incidental damages, arising out of the use of its products in such applications.

Patent statement

pSemi products are protected under one or more of the following U.S. patents: <http://patents.psemi.com>

Copyright and trademarks

©2026, pSemi Corporation. All rights reserved. The Peregrine Semiconductor name, Peregrine Semiconductor logo and UltraCMOS are registered trademarks and the pSemi name, pSemi logo, HaRP and DuNE are trademarks of pSemi Corporation in the U.S. and other countries.